ALPHA & OMEGA SEMICONDUCTOR

AO4446

30V N-Channel MOSFET

General Description

The AO4446 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and low gate resistance. This device is ideally suited for use in PWM applications.

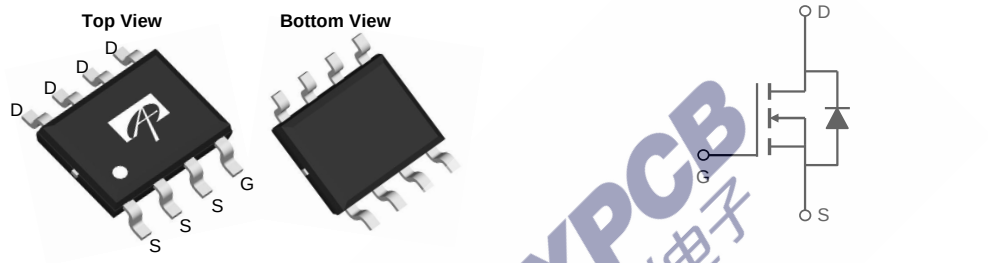
Product Summary

V_{DS} (V) = 30V
I_D = 15A (V_{GS} = 10V)
$R_{DS(ON)}$ < 8.5mΩ (V_{GS} = 10V)
$R_{DS(ON)}$ < 14.5mΩ (V_{GS} = 4.5V)

100% UIS Tested
100% Rg Tested

Green Product

SOIC-8



Absolute Maximum Ratings T_A=25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current [A]	T_A=25℃	I_D	15	A
	T_A=70℃		12	
Pulsed Drain Current [B]		I_{DM}	40	
Avalanche Current [B]		I_{AR}	20	A
Repetitive avalanche energy L=0.1mH [B]		E_{AR}	50	mJ
Power Dissipation	T_A=25℃	P_D	3	W
	T_A=70℃		2.1	
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	℃

Thermal Characteristics

Parameter		Symbol	Typ	Max	Units
Maximum Junction-to-Ambient [A]	t ≤ 10s	$R_{\theta JA}$	33	40	℃/W
Maximum Junction-to-Ambient [A]	Steady-State		59	75	℃/W
Maximum Junction-to-Lead [C]	Steady-State	$R_{\theta JL}$	16	24	℃/W

Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	I_D=250µA, V_{GS}=0V	30			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=24V, V_{GS}=0V			1	µA
		T_J=55℃			5	
I_{GSS}	Gate-Body leakage current	V_{DS}=0V, V_{GS}= ±20V			100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS} I_D=250µA	1	2.2	3	V
$I_{D(ON)}$	On state drain current	V_{GS}=10V, V_{DS}=5V	40			A
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS}=10V, I_D=15A		6.9	8.5	mΩ
		T_J=125℃		11	13.5	
		V_{GS}=4.5V, I_D=11A		11.8	14.5	mΩ
g_{FS}	Forward Transconductance	V_{DS}=5V, I_D=15A		27		S
V_{SD}	Diode Forward Voltage	I_S=1A,V_{GS}=0V		0.71	1	V
I_S	Maximum Body-Diode Continuous Current				4	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=15V, f=1MHz		1520	1825	pF
C_{oss}	Output Capacitance			306		pF
C_{rss}	Reverse Transfer Capacitance			214		pF
R_g	Gate resistance	V_{GS}=0V, V_{DS}=0V, f=1MHz		0.47	0.7	Ω
SWITCHING PARAMETERS						
Q_g(10V)	Total Gate Charge	V_{GS}=10V, V_{DS}=15V, I_D=15A		33.7	40	nC
Q_g(4.5V)	Total Gate Charge			17	20	nC
Q_{gs}	Gate Source Charge			6.2		nC
Q_{gd}	Gate Drain Charge			10		nC
$t_{D(on)}$	Turn-On DelayTime	V_{GS}=10V, V_{DS}=15V, R_L=1.0Ω, R_{GEN}=3Ω		7.2		ns
t_r	Turn-On Rise Time			8.2		ns
$t_{D(off)}$	Turn-Off DelayTime			22		ns
t_f	Turn-Off Fall Time			6.7		ns
t_{rr}	Body Diode Reverse Recovery Time	I_F=15A, dI/dt=100A/µs		24	30	ns
Q_{rr}	Body Diode Reverse Recovery Charge	I_F=15A, dI/dt=100A/µs		19		nC

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25℃. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using 80 µs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25℃. The SOA curve provides a single pulse rating.

Rev 3: Nov. 2010

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

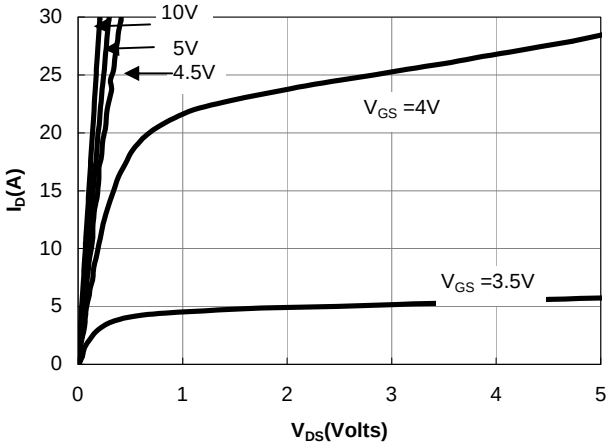


Figure 1: On-Regions CharacteristiCS

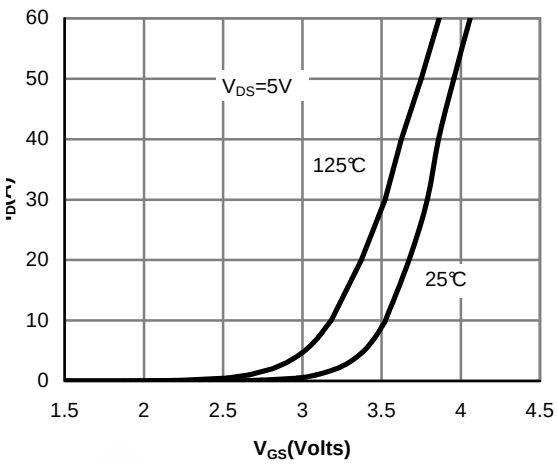


Figure 2: Transfer Characteristics

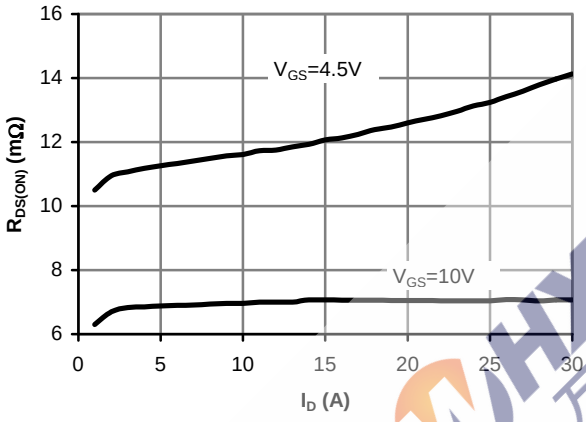


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

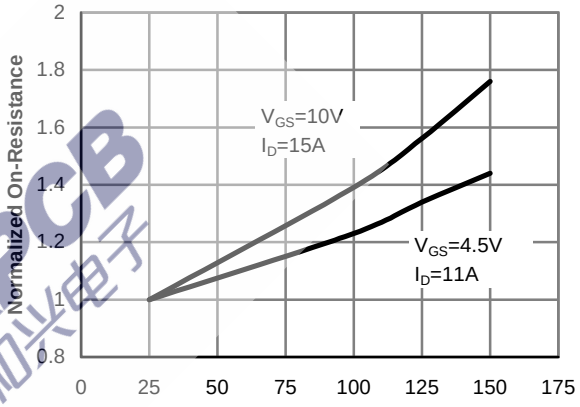


Figure 4: On-Resistance vs. Junction Temperature

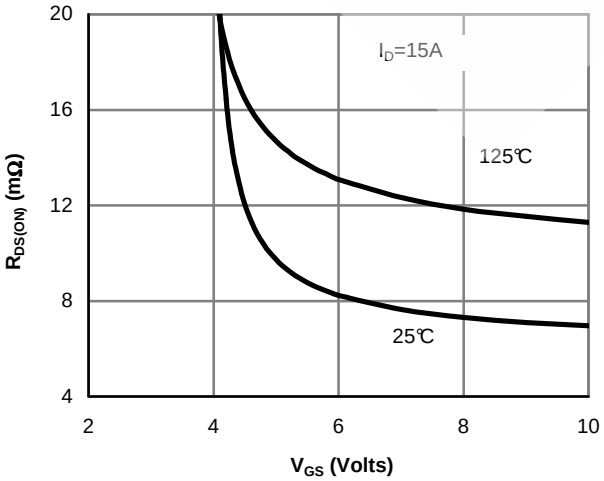


Figure 5: On-Resistance vs. Gate-Source Voltage

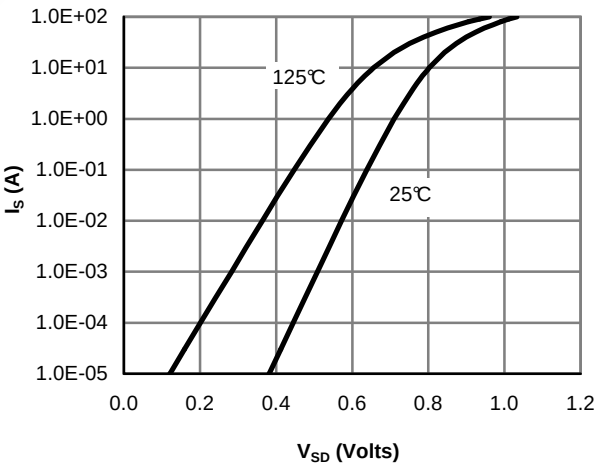


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

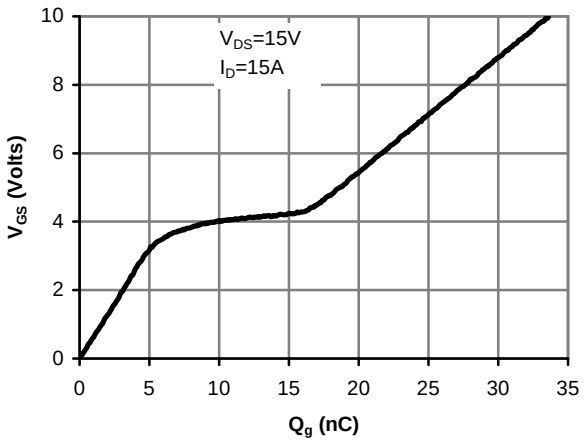


Figure 7: Gate-Charge Characteristics

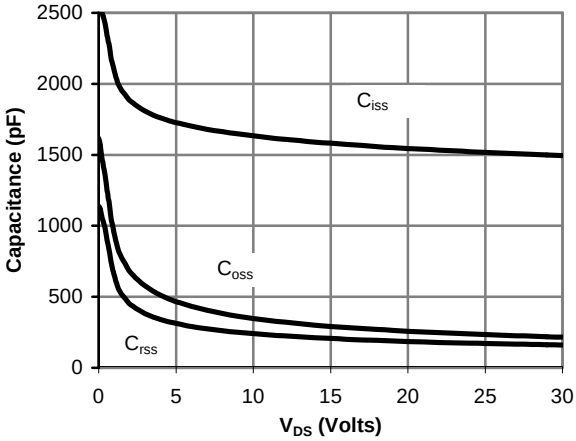


Figure 8: Capacitance Characteristics

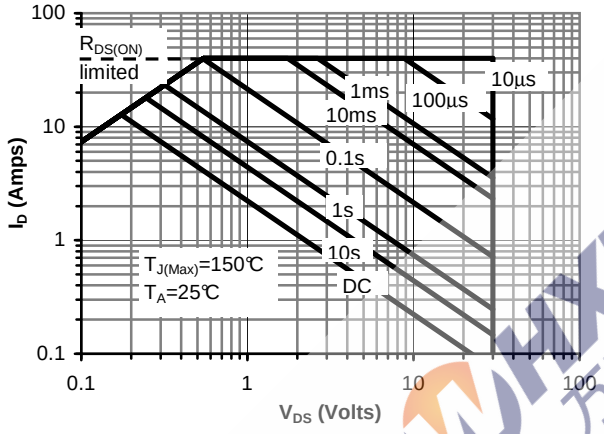


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

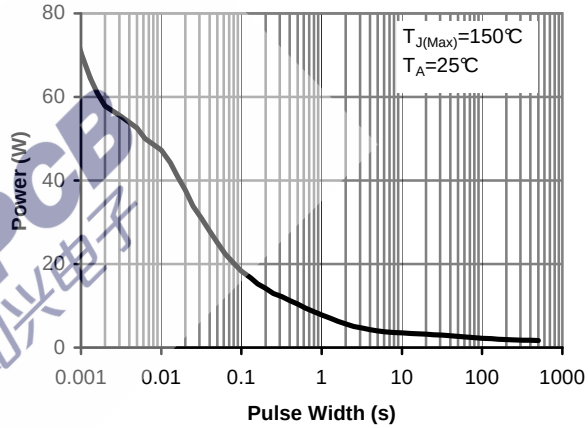


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

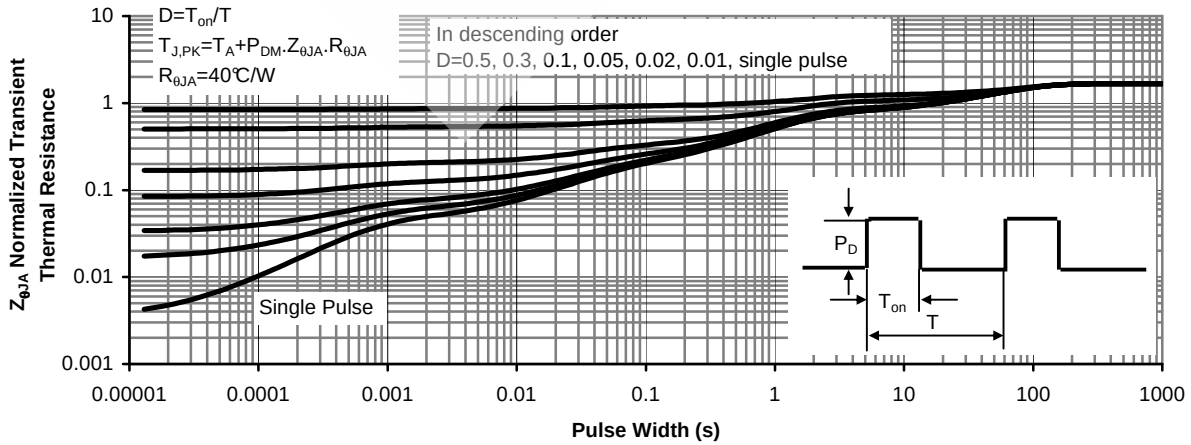


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)